# **CR800-Series Specifications**

Electrical specifications are valid over a -25° to +50°C range unless otherwise specified; non-condensing environment required. To maintain electrical specifications, Campbell Scientific recommends recalibrating dataloggers every two years. We recommend that the system configuration and critical specifications are confirmed with Campbell Scientific before purchase.

#### PROGRAM EXECUTION RATE

10 ms to one day @ 10 ms increments

#### ANALOG INPUTS (SE1-SE6 or DIFF1-DIFF3)

3 differential (DF) or 6 single-ended (SE) individually configured. Channel expansion provided by AM16/32B and AM25T multiplexers.

RANGES and RESOLUTION: Basic resolution (Basic Res) is the A/D resolution of a single conversion. Resolution of DF measurements with input reversal is half the Basic Res.

Range (mV) <sup>1</sup>	DF Res (μV) <sup>2</sup>	Basic Res (µV)
±5000	667	1333
±2500	333	667
±250	33.3	66.7
±25	3.33	6.7
±7.5	1.0	2.0
±2.5	0.33	0.67

<sup>&</sup>lt;sup>1</sup>Range overhead of ~9% on all ranges guarantees that full-scale values will not cause over range.

#### ACCURACY3:

 $\pm (0.06\%$  of reading + offset), 0° to 40°C  $\pm (0.12\%$  of reading + offset), -25° to 50°C

±(0.18% of reading + offset), -55° to 85°C (-XT only)

<sup>3</sup>The sensor and measurement noise are not included and the offsets are the following:

Offset for DF w/input reversal = 1.5·Basic Res + 1.0  $\mu$ V Offset for DF w/o input reversal = 3·Basic Res + 2.0  $\mu$ V Offset for SE = 3·Basic Res + 3.0  $\mu$ V

#### ANALOG MEASUREMENT SPEED:

Integra-			Total	Time <sup>5</sup>
tion Type/	Integra-	Settling	SE w/	DF w/
Code	tion Time	Time	No Rev	Input Rev
250	250 µs	450 µs	~1 ms	~12 ms
60 Hz <sup>4</sup>	16.67 ms	3 ms	~20 ms	~40 ms
50 Hz <sup>4</sup>	20.00 ms	3 ms	~25 ms	~50 ms

<sup>&</sup>lt;sup>4</sup>AC line noise filter.

INPUT NOISE VOLTAGE: For DF measurements with input reversal on ±2.5 mV input range; digital resolution dominates for higher ranges.

250 μs Integration: 50/60 Hz Integration: 0.34 μV RMS 0.19 μV RMS

INPUT LIMITS: ±5 V

DC COMMON MODE REJECTION: >100 dB NORMAL MODE REJECTION: 70 dB @ 60 Hz when using 60 Hz rejection

SUSTAINED INPUT VOLTAGE W/O DAMAGE: ±16 Vdc max.

INPUT CURRENT:  $\pm 1$  nA typical,  $\pm 6$  nA max. @ 50°C;  $\pm 90$  nA @ 85°C

INPUT RESISTANCE: 20 Gohms typical ACCURACY OF BUILT-IN REFERENCE JUNCTION THERMISTOR (for thermocouple measurements):

±0.3°C, -25° to 50°C ±0.8°C, -55° to 85°C (-XT only)

#### **ANALOG OUTPUTS (Vx1-Vx2)**

2 switched voltage, active only during measurement, one at a time.

RANGE AND RESOLUTION: Voltage outputs programmable between  $\pm 2.5 \text{ V}$  with 0.67 mV resolution.

 $\begin{array}{l} V_x \ ACCURACY: \pm (0.06\% \ of \ setting + 0.8 \ mV), \ 0^{\circ} \ to \ 40^{\circ}C \\ \pm (0.12\% \ of \ setting + 0.8 \ mV), \ -25^{\circ} \ to \ 50^{\circ}C \\ \pm (0.18\% \ of \ setting + 0.8 \ mV), \ -55^{\circ} \ to \ 85^{\circ}C \ (-XT \ only) \end{array}$ 

V<sub>x</sub> FREQUENCY SWEEP FUNCTION: Switched outputs provide a programmable swept frequency, 0 to 2500 mv square waves for exciting vibrating wire transducers. CURRENT SOURCING/SINKING: ±25 mA

#### RESISTANCE MEASUREMENTS

MEASUREMENT TYPES: The CR800-series provides ratiometric measurements of 4- and 6-wire full bridges, and 2-, 3-, and 4-wire half bridges. Precise, dual polarity excitation using any of the 3 switched voltage excitations e

VOLTAGE RATIO ACCURACY<sup>6</sup>: Assuming excitation voltage of at least 1000 mV, not including bridge resistor error.

±(0.04% of voltage reading + offset)/V,

<sup>6</sup>The sensor and measurement noise are not included and the offsets are the following:

Offset for DF w/input reversal = 1.5-Basic Res + 1.0  $\mu$ V Offset for DF w/o input reversal = 3-Basic Res + 2.0  $\mu$ V Offset for SE = 3-Basic Res + 3.0  $\mu$ V

Offset values are reduced by a factor of 2 when excitation reversal is used.

#### PERIOD AVERAGING MEASUREMENTS

Any of the 6 SE analog inputs can be used for period averaging. Accuracy is  $\pm (0.01\%$  of reading + resolution), where resolution is 136 ns divided by the specified number of cycles to be measured.

INPUT AMPLITUDE AND FREQUENCY:

	Input	Signal (peak to peak) <sup>7</sup>		Min Pulse	Max <sup>8</sup>
Voltage	Range			Width	Freq
Gain	(±mV)	Min. (mV)	Max (V)	(µV)	(kHz)
1	2500	500	10	2.5	200
10	250	10	2	10	50
33	25	5	2	62	8
100	2.5	2	2	100	5

<sup>&</sup>lt;sup>7</sup>With signal centered at the datalogger ground.

## PULSE COUNTERS (P1-P2)

2 inputs individually selectable for switch closure, high frequency pulse, or low-level ac. Independent 24-bit counters for each input.

MAXIMUM COUNTS PER SCAN: 16.7 x 106

SWITCH CLOSURE MODE:

Minimum Switch Closed Time: 5 ms Minimum Switch Open Time: 6 ms

Max. Bounce Time: 1 ms open w/o being counted

HIGH FREQUENCY PULSE MODE: Maximum Input Frequency: 250 kHz

Maximum Input Voltage: ±20 V
Voltage Thresholds: Count upon transition from

below 0.9 V to above 2.2 V after input filter with 1.2 µs time constant.

LOW LEVEL AC MODE: Internal ac coupling removes dc offsets up to  $\pm 0.5$  V.

Input Hysteresis: 12 mV @ 1 Hz Maximum ac Input Voltage: ±20 V Minimum ac Input Voltage:

Sine Wave (mV RMS)	Range(Hz)
20	1.0 to 20
200	0.5 to 200
2000	0.3 to 10,000
5000	0.3 to 20,000

#### DIGITAL I/O PORTS (C1-C4)

4 ports software selectable, as binary inputs or control outputs. They also provide edge timing, subroutine interrupts/wake up, switch closure pulse counting, high frequency pulse counting, asynchronous communications (UART), SDI-12 communications, and SDM communications.

HIGH FREQUENCY MAX: 400 kHz

SWITCH CLOSURE FREQUENCY MAX: 150 Hz

EDGE TIMING RESOLUTION: 540 ns

OUTPUT VOLTAGES (no load): high 5.0 V ±0.1 V;

low < 0.1

OUTPUT RESISTANCE: 330 ohms

INPUT STATE: high 3.8 to 16 V; low -8.0 to 1.2 V

INPUT HYSTERISIS: 1.4 V INPUT RESISTANCE: 100 kohms

#### SWITCHED 12 V (SW12)

One independent 12 V unregulated source is switched on and off under program control. Thermal fuse hold current = 900 mA @ 20°C, 650 mA @ 50°C, 360 mA @ 85°C.

#### CE COMPLIANCE

STANDARD(S) TO WHICH CONFORMITY IS DECLARED: IEC61326:2002

# COMMUNICATIONS

RS-232 PORTS:

9-pin: DCE port for battery-powered computer or non-CSI modem connection.

COM1 to COM2: Two independent Tx/Rx pairs on control ports (non-isolated); 0 to 5 VUART

Baud Rates: selectable from 300 bps to 115.2 kbps. Default Format: 8 data bits; 1 stop bits; no parity Optional Formats: 7 data bits; 2 stop bits; odd, even parity

CS I/O PORT: Interface with CSI peripherals

SDI-12: Digital control ports 1 or 3 are individually configured and meet SDI-12 Standard version 1.3 for datalogger mode. Up to ten SDI-12 sensors are supported per port.

PROTOCOLS SUPPORTED: PakBus, Modbus, DNP3, FTP, HTTP, XML, POP3, SMTP, Telnet, NTCIP, NTP, SDI-12. SDM

#### **SYSTEM**

PROCESSOR: Renesas H8S 2322 (16-bit CPU with 32-bit internal core)

MEMORY: 2 MB of Flash for operating system; 4 MB of battery-backed SRAM for CPU usage, program storage and data storage

CLOCK ACCURACY: ±3 min. per year. Correction via GPS optional.

### SYSTEM POWER REQUIREMENTS

VOLTAGE: 9.6 to 16 Vdc (reverse polarity protected)

EXTERNAL BATTERIES: 12 Vdc nominal

TYPICAL CURRENT DRAIN:

Sleep Mode: 0.7 mA (0.9 mA max.) 1 Hz Sample Rate (1 fast SE meas.): 1 mA 100 Hz Sample Rate (1 fast SE meas.): 16.2 mA 100 Hz Sample Rate (1 fast SE meas. w/RS-232 communication): 27.6 mA

CR1000KD or CR850 Keyboard Display On (no backlight): add 7 mA to current drain CR1000KD or CR850 Keyboard Display On (backlight on): add 100 mA to current drain

# PHYSICAL SPECIFICATIONS

DIMENSIONS: 9.5" x 4.1" x 2" (24.1 x 10.4 x 5.1 cm); additional clearance required for serial cable and sensor leads.

WEIGHT: 1.5 lbs (0.7 kg)

#### WARRANTY

3 years against defects in materials and workmanship.



<sup>&</sup>lt;sup>2</sup>Resolution of DF measurements with input reversal.

<sup>&</sup>lt;sup>5</sup>Includes 250 μs for conversion to engineering units.

<sup>8</sup>The maximum frequency = 1/(Twice Minimum Pulse Width) for 50% of duty cycle signals.